•	Search Notes				

Application/Control No.	Applicant(s)/Patent under Reexamination
10/730,472	TAKADA ET AL.
Examiner	Art Unit
Tamai I E Mad	2024

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Class	Subclass	Date	Examiner
310	40mm, 90, 309, 156.32		
384	114, 371		
	397		
360	99.08	10/18/2005	KIT
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INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
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